

# DXG1PH60P-40N

#### **RF Power GaN Transistor**

## 1. Product profile

# dynax

#### 1.1 General description

DXG1PH60P-40N is a 40 W unmatched RF GaN HEMT Transistor with first generation RF GaN technology from Dynax, which is ideal for cellular base station applications at frequencies from DC to 6 GHz, and general purpose application.

Table 1. Typical performance <sup>1</sup>

Freq	P <sub>sat</sub> <sup>2</sup>	P <sub>avg</sub> <sup>3</sup>	η <sub>D</sub> <sup>3</sup>	G <sub>P</sub> <sup>3</sup>	ACPR <sup>3</sup>
(MHz)	(dBm)	(dBm)	(%)	(dB)	(dBc)
1805.0	46.4	38.5	48.0	20.6	-31.0
1842.5	46.4	38.5	49.0	21.0	-31.0
1880.0	46.4	38.5	49.0	20.9	-31.0

 $<sup>^{1}</sup>$  Typical Doherty performance in Dynax Demo with the device soldered onto the heatsink, test condition:  $V_{DS}$  = 48 V,  $I_{DQA}$  = 40 mA,  $V_{GSB}$  = - 5.1 V.

#### 1.2 Features and benefits

- > High efficiency, high gain
- > Excellent ruggedness
- > Excellent reliability

#### 1.3 Applications

- > Small cell base station
- > Broadband general purpose amplifier
- Public mobile radios
- > Test instrumentation

#### 1.4 Lead-free and RoHS compliant



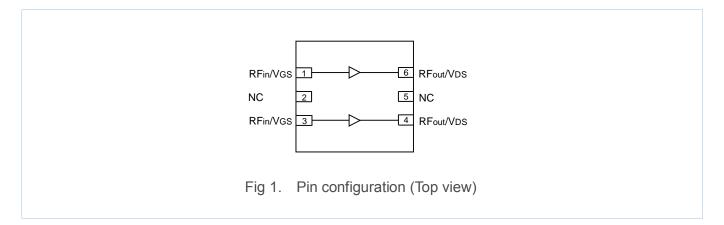


<sup>&</sup>lt;sup>2</sup> Test condition: Input signal Pulsed CW, Pulse width = 100 μs, Duty cycle = 10 %.

<sup>&</sup>lt;sup>3</sup> Test condition: Single-Carrier W-CDMA, IQ magnitude clipping, Input signal PAR = 7.5 dB @ 0.01 % probability on CCDF. ACPR measured in 3.84 MHz channel bandwidth @ ±5 MHz offset.



## 2. Pinning information



# 3. Ordering information

**Table 2. Ordering information** 

Part number	Marking	Package type	Packaging information
			Tray: Suffix = 416 units
DXG1PH60P-40N	DX4A	DFN 7×6.5mm	Tape and Reel: Suffix = 1000 units; 16 mm Tape width; 13-inch Reel

# 4. Maximum ratings

Table 3. Maximum ratings

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V <sub>DSS</sub>	150	V
Gate-Source Voltage	V <sub>G</sub> S	-10 ~ +2	V
Operating Voltage	V <sub>DS</sub>	0 ~ +55	V
Maximum Forward Gate Current	IGMAX	3.6	mA
Storage Temperature Range	T <sub>STG</sub>	- 65 ~ +150	°C
Operating Junction Temperature	TJ	225	°C
Absolute Maximum Channel Temperature <sup>1</sup>	T <sub>MAX</sub>	275	°C

<sup>&</sup>lt;sup>1</sup> Functional operation above 225°C has not been characterized and is not implied. Operation at  $T_{MAX}$  (275°C) reduces median time to failure by an order of magnitude; Operation beyond  $T_{MAX}$  could cause permanent damage.



## 5. Thermal characteristics

**Table 4. Thermal characteristics** 

Parameter	Symbol	Value	Unit
Side A, Carrier			
Thermal Resistance at Average Power by Infrared Measurement,			
Active Die Surface-to-Case	R <sub>thjc</sub> (IR)	8.0	°C/W
$T_{\text{base-plate}} = 85^{\circ}\text{C}, P_D = 4.7 \text{ W}$			
Thermal Resistance at Average Power by Finite Element Analysis,			
Junction-to-Case	R <sub>thjc</sub> (FEA)	11.8	°C/W
$T_{\text{base-plate}} = 85^{\circ}\text{C}, P_{\text{D}} = 4.7 \text{ W}$			
Side B, Peaking			
Thermal Resistance at Average Power by Infrared Measurement,			
Active Die Surface-to-Case	R <sub>thjc</sub> (IR)	8.0	°C/W
$T_{\text{base-plate}} = 85^{\circ}\text{C}, P_D = 4.7 \text{ W}$			
Thermal Resistance at Average Power by Finite Element Analysis,			
Junction-to-Case	$R_{thjc}(FEA)$	11.8	°C/W
$T_{\text{base-plate}} = 85^{\circ}\text{C}, P_D = 4.7 \text{ W}$			

# 6. ESD protection characteristics

### Table 5. ESD protection characteristics

Test methodology	Class
Human Body Model (per JS-001-2012)	1A (> 250 V)
Charged Device Model (per JESD22-C101F)	C2 (> 500 V)

# 7. Moisture sensitivity level

Table 6. Moisture sensitivity level

Test methodology	Class
Moisture Sensitivity Level (per J-STD-020)	Level 3



## 8. Electrical characteristics (TA = 25°C unless otherwise noted)

Table 7. DC characteristics

Parameter	Symbol	Min.	Тур.	Max.	Unit
Side A, Carrier				'	
Drain-Source Leakage Current (V <sub>GS</sub> = -10 V, V <sub>DS</sub> = 150 V)	I <sub>DSS</sub>	-	-	1.8	mA
Drain-Source Breakdown Voltage (V <sub>GS</sub> = -10 V, I <sub>D</sub> = 1.8 mA)	V <sub>(BR)DSS</sub>	150	-	-	V
Gate Threshold Voltage (V <sub>DS</sub> = 48 V, I <sub>D</sub> = 1.8 mA)	V <sub>GS(th)</sub>	-4.0	-3.2	-1.0	V
Gate Quiescent Voltage (V <sub>DS</sub> = 48 V, I <sub>D</sub> = 40 mA)	V <sub>GS(Q)</sub>	-	-3.0	-	V
Side B, Peaking			1		
Drain-Source Leakage Current (V <sub>GS</sub> = -10 V, V <sub>DS</sub> = 150 V)	IDSS	-	-	1.8	mA
Drain-Source Breakdown Voltage (V <sub>GS</sub> = -10 V, I <sub>D</sub> = 1.8 mA)	V <sub>(BR)DSS</sub>	150	-	-	V
Gate Threshold Voltage (V <sub>DS</sub> = 48 V, I <sub>D</sub> = 1.8 mA)	V <sub>GS(th)</sub>	-4.0	-3.2	-1.0	V
Gate Quiescent Voltage $(V_{DS} = 48 \text{ V}, I_D = 40 \text{ mA})$	$V_{GS(Q)}$	-	-3.0	-	V

#### Table 8. RF characteristics (Typical Doherty performance – 1880 MHz) <sup>1</sup>

			•		
Parameter	Symbol	Min.	Тур.	Max.	Unit
Peak Output Power <sup>2</sup>	P <sub>sat</sub>	44.6	45.6	-	dBm
Drain Efficiency <sup>3</sup>	η <sub>D</sub>	37.0	44.0	-	%
Power Gain <sup>3</sup>	G₽	16.6	18.2	19.8	dB

<sup>&</sup>lt;sup>1</sup> Typical Doherty performance in Dynax DXG1PH60P-40N production test fixture, test condition:  $V_{DS}$  = 48 V,  $I_{DQA}$  = 40 mA,  $V_{GSB}$  = -2.1 V +  $V_{GSQ}$  @ 20 mA.

#### Table 9. Load mismatch

Parameter	Result
VSWR 10:1 at V <sub>DS</sub> = 48 V,	
40 W Pulsed CW output power,	No device damage
Pulse width = 100 $\mu$ s, Duty cycle = 10%.	

 $<sup>^2</sup>$  Test condition: Pulsed CW, Pulse width = 100  $\mu$ s, Duty cycle = 10 %.

<sup>&</sup>lt;sup>3</sup> Test condition: P<sub>out</sub> = 38.5 dBm Avg., Single-Carrier W-CDMA, IQ magnitude clipping, Input signal PAR = 7.5 dB @ 0.01 % probability on CCDF.



#### 9. Test information

#### 9.1 Graphic Data

#### 9.1.1 Pulsed CW

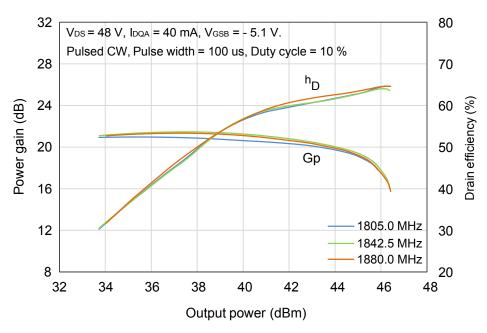


Fig 2. Power gain, Drain efficiency vs. Pulse output power

#### 9.1.2 Single-Carrier W-CDMA

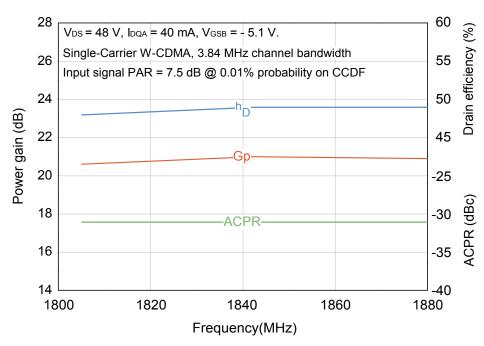


Fig 3. Power gain, Drain efficiency, ACPR vs. Frequency Single-Carrier W-CDMA @ P<sub>out</sub> = 7.1 Watts Avg.



# 10. Impedance information

Table 10. Typical impedance of carrier <sup>1</sup>

Maximum Output Power							
Freq (MHz)	Z <sub>S</sub> (Ω)	$Z_{L}\left( \Omega \right)$	G <sub>P</sub> (dB)	P <sub>sat</sub> (dBm)	P <sub>sat</sub> (W)	η⊳ (%)	
1800	4.3 + j12.1	29.8 + j15.1	24.0	43.8	24.0	66.2	
2600	4.0 - j0.5	26.0 + j10.5	21.0	43.6	22.9	65.5	
3500	6.1 - j15.1	22.6 + j3.6	19.3	43.4	21.9	62.0	
		Maximum l	Drain Efficier	ісу			
Freq (MHz)	Z <sub>S</sub> (Ω)	$Z_{L}\left( \Omega \right)$	G <sub>P</sub> (dB)	P <sub>sat</sub> (dBm)	P <sub>sat</sub> (W)	η <sub>D</sub> (%)	
1800	4.3 + j12.1	21.9 + j36.5	24.2	42.5	17.8	80.6	
2600	4.0 - j0.5	11.6 + j26.1	21.5	41.7	14.8	79.5	
3500	6.1 - j15.1	11.6 + j12.2	20.3	42.3	17.0	72.2	

Table 11. Typical impedance of peaking <sup>2</sup>

Maximum Output Power							
Freq (MHz)	Z <sub>S</sub> (Ω)	$Z_{L}\left( \Omega \right)$	G <sub>P</sub> (dB)	P <sub>sat</sub> (dBm)	P <sub>sat</sub> (W)	η⊳ (%)	
1800	4.3 + j12.1	29.8 + j15.1	24.0	43.8	24.0	66.2	
2600	4.0 - j0.5	26.0 + j10.5	21.0	43.6	22.9	65.5	
3500	6.1 - j15.1	22.6 + j3.6	19.3	43.4	21.9	62.0	
		Maximum I	Drain Efficier	ісу			
Freq (MHz)	Z <sub>S</sub> (Ω)	$Z_{L}\left( \Omega \right)$	G <sub>P</sub> (dB)	P <sub>sat</sub> (dBm)	P <sub>sat</sub> (W)	η <sub>D</sub> (%)	
1800	4.3 + j12.1	21.9 + j36.5	24.2	42.5	17.8	80.6	
2600	4.0 - j0.5	11.6 + j26.1	21.5	41.7	14.8	79.5	
3500	6.1 - j15.1	11.6 + j12.2	20.3	42.3	17.0	72.2	

 $<sup>^{1}</sup>$  VDS = 48 V, IDQA = 40 mA, Pulsed CW, Pulse width = 100  $\mu$ s, Duty cycle = 10 %.

 $<sup>^2</sup>$  VDS = 48 V, IDQB = 40 mA, Pulsed CW, Pulse width = 100  $\mu$ s, Duty cycle = 10 %.

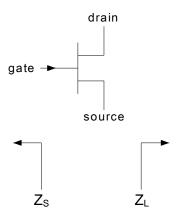


Fig 4. Definition of transistor impedance



## 11. Median lifetime

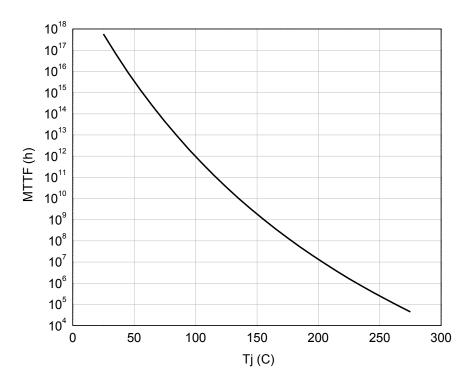
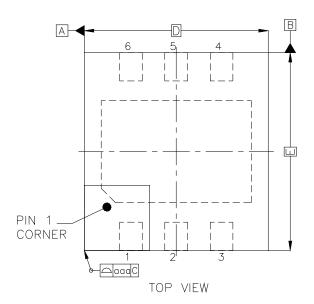
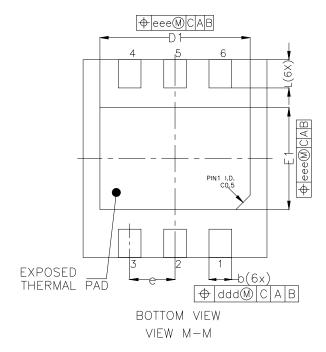


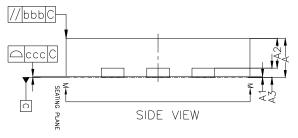
Fig 5. Median lifetime vs. channel temperature



# 12. Package outline







DECORUPTION	DECODIDION		ı	MILLIMETER		
DESCRIPTION		SYMBOL	MIN	NOM	MAX	
TOTAL THICKNESS		А	0.80	0.85	0.90	
STAND OFF		A1	0.00		0.05	
MOLD THICKNESS		A2	0.60	0.65	0.70	
L/F THICKNESS		A3		0.203 REF		
BODY SIZE	X	D	6.43	6.50	6.57	
DODI SIZE	Y	Е	6.93	7.00	7.07	
LEAD PITCH	е	1.60 BSC				
LEAD WIDTH		b	0.75	0.80	0.85	
LEAD LENGTH		L	0.95	1.00	1.05	
EP SIZE		D1	5.26	5.31	5.36	
EF SIZE		E1	3.55	3.60	3.65	
	Toleran	ice of form o	and position			
PACKAGE EDGE TOLERANCE		aaa	0.1			
MOLD FLATNESS		bbb		0.1		
LEAD COPLANARITY		ccc	0.08			
LEAD POSITION OFFSET		ddd		0.1		
EXPOSED PAD OFFS	ET	eee	0.1			

Fig 6. Package outline —— DFN 7×6.5mm



#### 13. Abbreviations

Table 12. Abbreviations

Acronym	Description	
CW	Continuous Waveform	
ESD	Electro-Static Discharge	
GaN	Gallium Nitride	
HEMT	High Electron Mobility Transistor	
MTTF	Median Time To Failure	
VSWR	Voltage Standing Wave Ratio	

## 14. Legal information

#### 14.1 Datasheet status

Document status	Product status	Definition
Objective [short] datasheet	Engineering sample	This document contains data from the objective specification for product development.
Preliminary [short] datasheet	Engineering sample	This document contains data from the preliminary specification.
Production [short] datasheet	Mass product	This document contains the product specification.

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